Search Notes

10/791,926 Examiner

Emmanuel S. Luk

Applicant(s)/Patent under Reexamination

HOCHENG ET AL.

Art Unit

1722

SEARCHED				
Class	Subclass	Date	Examiner	
425	149	3/2/2007	EL	
425	385	3/2/2007	EL	
977	887	3/2/2007	EL	
264	293	3/2/2007	Éŗ	
264	406	3/2/2007	EL	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST text search	3/2/2007	EL		
inventor search	3/2/2007	EL		